







CSD19533KCS SLPS482C - DECEMBER 2013 - REVISED MAY 2024

CSD19533KCS, 100V N-Channel NexFET™ Power MOSFET

1 Features

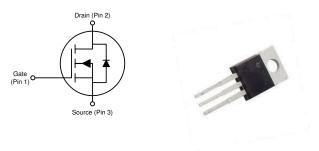
- Ultra-low Q_g and Q_{gd}
- Low thermal resistance
- Avalanche rated
- Pb free terminal plating
- RoHS compliant
- Halogen free
- TO-220 plastic package

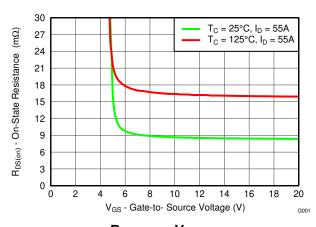
2 Applications

- Secondary side synchronous rectifier
- Motor control

3 Description

This 100V, 8.7mΩ, TO-220 NexFET[™] power MOSFET is designed to minimize losses in power conversion applications.





R_{DS(on)} vs V_{GS}

Product Summary

T _A = 25°	C	TYPICAL VA	UNIT	
V _{DS}	Drain-to-Source Voltage	100	100	
Qg	Gate Charge Total (10V)	27		nC
Q _{gd}	Gate Charge Gate-to-Drain	5.4		nC
В	Drain-to-Source On-Resistance	V _{GS} = 6V 9.7		mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 10V 8.7		mΩ
V _{GS(th)}	Threshold Voltage	Voltage 2.8		V

Ordering Information(1)

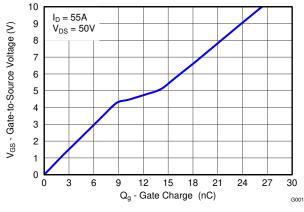
Device	Package	Media	Qty	Ship
CSD19533KCS	TO-220 Plastic Package	Tube	50	Tube

For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT
V _{DS}	Drain-to-Source Voltage	100	V
V _{GS}	Gate-to-Source Voltage	±20	V
	Continuous Drain Current (Package limited)	100	
I _D	Continuous Drain Current (Silicon limited), T _C = 25°C	86	Α
	Continuous Drain Current (Silicon limited), T _C = 100°C	61	
I _{DM}	Pulsed Drain Current (1)	207	Α
P _D	Power Dissipation	188	W
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-55 to 175	°C
E _{AS}	Avalanche Energy, single pulse $I_D = 46A$, $L = 0.1$ mH, $R_G = 25\Omega$	106	mJ

Max R_{θJC} = 0.8°C/W, pulse duration ≤100μs, Duty cycle ≤1%



Gate Charge



Table of Contents

1 Features	1	5.2 Documentation Support
2 Applications		5.3 Receiving Notification of Documentation Updates7
3 Description	1	5.4 Support Resources7
4 Specifications		5.5 Trademarks7
4.1 Electrical Characteristics	3	5.6 Electrostatic Discharge Caution7
4.2 Thermal Information	3	5.7 Glossary
4.3 Typical MOSFET Characteristics	4	6 Revision History8
		7 Mechanical, Packaging, and Orderable Information 9
5.1 Third-Party Products Disclaimer		, , ,



4 Specifications

4.1 Electrical Characteristics

(T_A = 25°C unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS				
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0V, I _D = 250μA	100		V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0V, V _{DS} = 80V		1	μA
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0V, V _{GS} = 20V		100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	2.2 2.8	3.4	V
D	Drain-to-Source On-Resistance	V _{GS} = 6V, I _D = 55A	9.7	12.2	mΩ
R _{DS(on)}	Dialii-to-Source Ori-Resistance	V _{GS} = 10V, I _D = 55A	8.7	10.5	mΩ
g _{fs}	Transconductance	V _{DS} = 10V, I _D = 55A	115		S
DYNAM	IC CHARACTERISTICS				
C _{iss}	Input Capacitance		2050	2670	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 50V, f = 1MHz$	395	514	pF
C _{rss}	Reverse Transfer Capacitance		9.6	12.5	pF
R _G	Series Gate Resistance		1.2	2.4	Ω
Q _g	Gate Charge Total (10V)		27	35	nC
Q _{gd}	Gate Charge Gate-to-Drain	V - 50V I - 55A	5.4		nC
Q _{gs}	Gate Charge Gate-to-Source	$V_{DS} = 50V, I_{D} = 55A$	9		nC
Q _{g(th)}	Gate Charge at V _{th}		3.9		nC
Q _{oss}	Output Charge	V _{DS} = 50V, V _{GS} = 0V	79		nC
t _{d(on)}	Turn On Delay Time		7		ns
t _r	Rise Time	V _{DS} = 50V, V _{GS} = 10V,	5		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 55A$, $R_G = 0\Omega$	12		ns
t _f	Fall Time		2		ns
DIODE (CHARACTERISTICS		,		
V _{SD}	Diode Forward Voltage	I _{SD} = 55A, V _{GS} = 0V	0.9	1.1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 50V, I _F = 55A,	211		nC
t _{rr}	Reverse Recovery Time	di/dt = 300A/μs	77		ns

4.2 Thermal Information

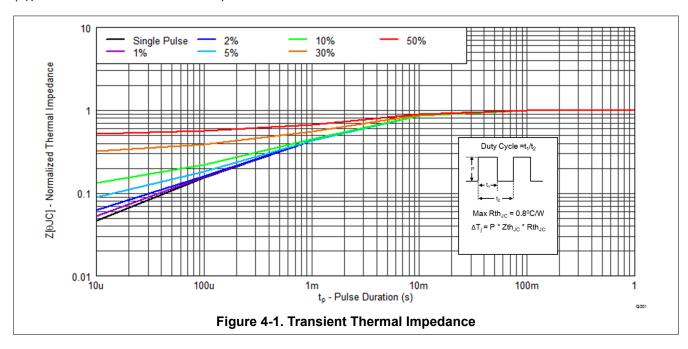
(T_A = 25°C unless otherwise stated)

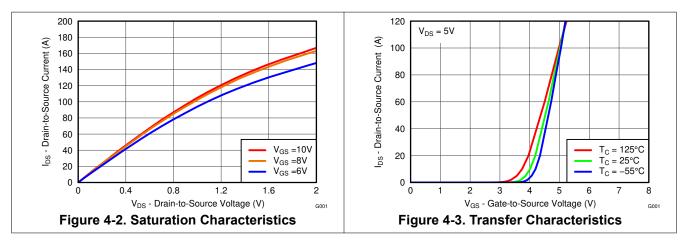
(· A -					
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance			0.8	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance			62	C/VV

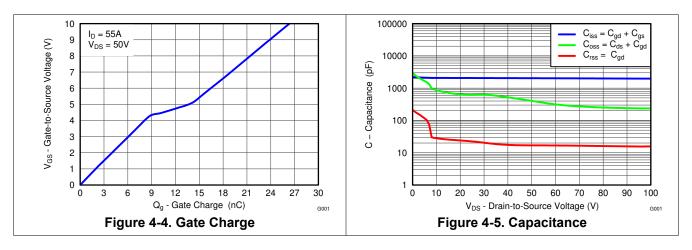


4.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$







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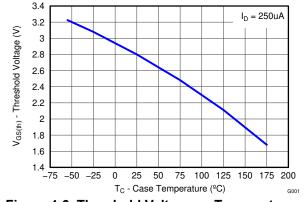


Figure 4-6. Threshold Voltage vs Temperature

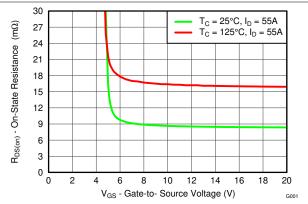


Figure 4-7. On-State Resistance vs Gate-to-Source Voltage

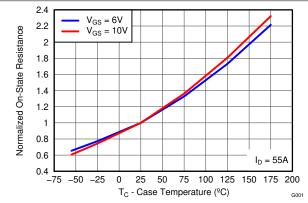


Figure 4-8. Normalized On-State Resistance vs
Temperature

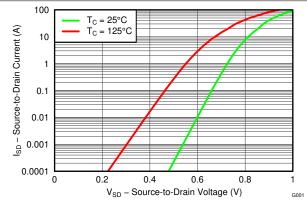


Figure 4-9. Typical Diode Forward Voltage

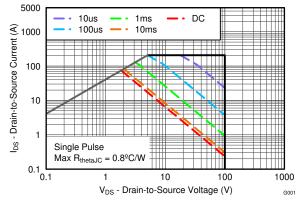


Figure 4-10. Maximum Safe Operating Area

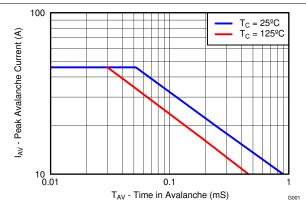
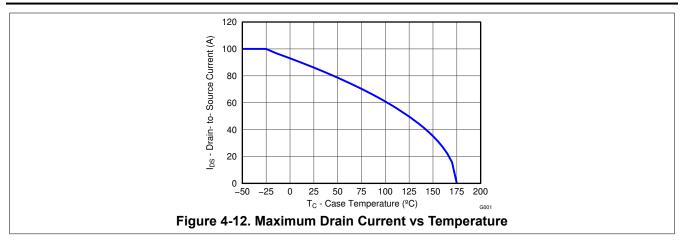


Figure 4-11. Single Pulse Unclamped Inductive Switching





5 Device and Documentation Support

5.1 Third-Party Products Disclaimer

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5.2 Documentation Support

5.2.1 Related Documentation

5.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

5.4 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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5.5 Trademarks

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5.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

Product Folder Links: CSD19533KCS



6 Revision History

Changes from Revision B (January 2015) to Revision C (May 2024)	Page				
 Updated the numbering format for tables, figures, and cross-references throughout the document Changes from Revision A (July 2014) to Revision B (January 2015) 					
Changes from Revision A (July 2014) to Revision B (January 2015)	Page				
Changed Q _{rr} to 211nC	<u> </u>				
Changes from Revision * (December 2013) to Revision A (July 2014)	Page				
Pulsed drain current increased from 104 to 207A	1				
Updated pulsed current conditions	1				
Updated Figure 4-10 to reflect increased pulsed drain current	4				

Product Folder Links: CSD19533KCS



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
CSD19533KCS	Active	Production	TO-220 (KCS) 3	50 TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD19533KCS
CSD19533KCS.B	Active	Production	TO-220 (KCS) 3	50 TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD19533KCS

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TUBE

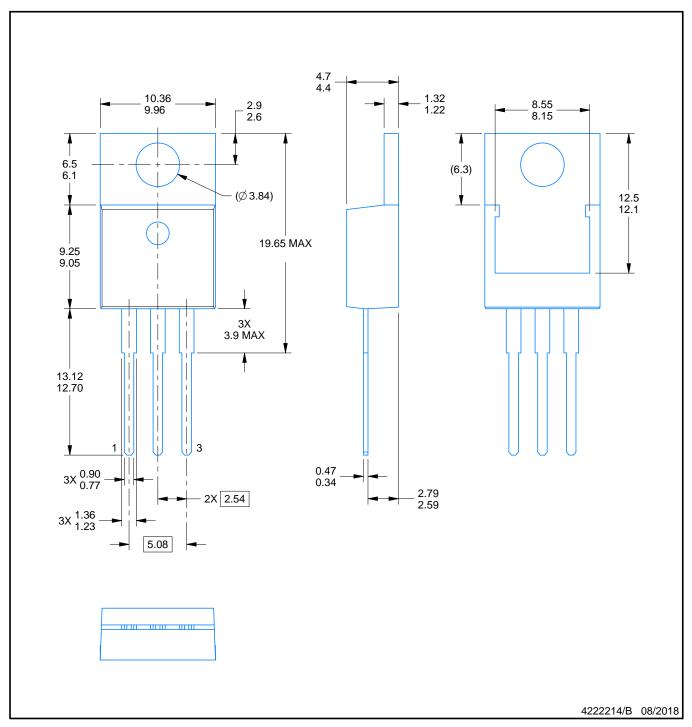


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CSD19533KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD19533KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD19533KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6
CSD19533KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6



TO-220



NOTES:

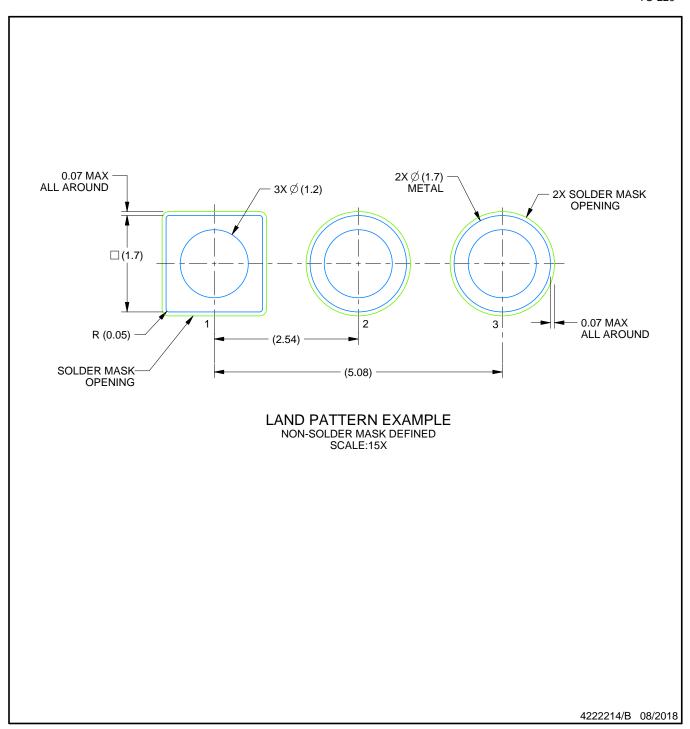
- 1. Dimensions are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Reference JEDEC registration TO-220.



TO-220



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